
2SJ549(L), 2SJ549(S)

Silicon P Channel MOS FET
High Speed Power Switching

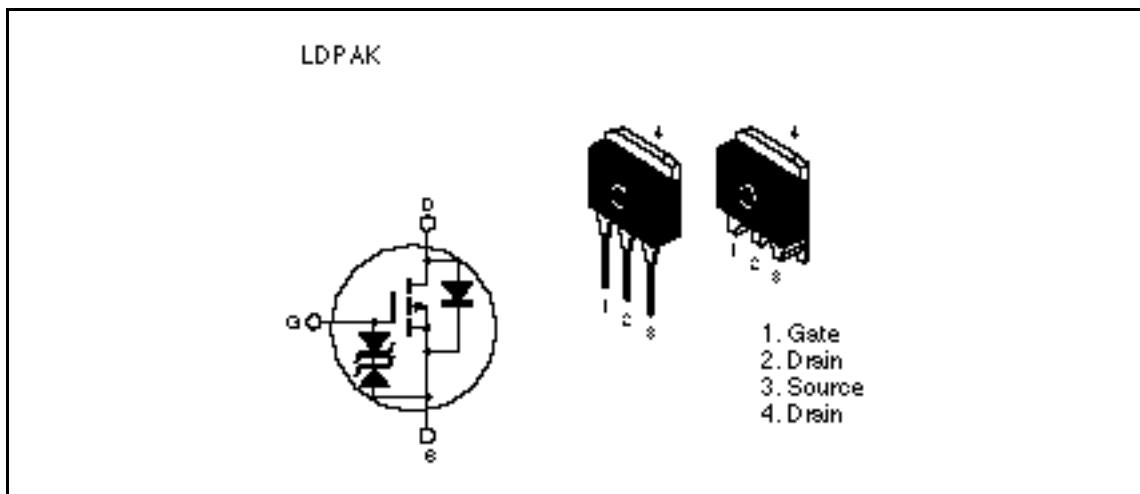
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ADE-208-644A (Z)
2nd. Edition
Jun 1998

Features

- Low on-resistance
 $R_{DS(on)} = 0.11$ typ.
- Low drive current
- 4 V gate drive devices
- High speed switching

Outline



2SJ549(L),2SJ549(S)

Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V _{DSS}	-60	V
Gate to source voltage	V _{GSS}	±20	V
Drain current	I _D	-12	A
Drain peak current	I _{D(pulse)} ^{Note1}	-48	A
Body-drain diode reverse drain current	I _{DR}	-12	A
Avalanche current	I _{AP} ^{Note3}	-12	A
Avalanche energy	E _{AR} ^{Note3}	12	mJ
Channel dissipation	Pch ^{Note2}	50	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note: 1. PW 10μs, duty cycle 1 %

2. Value at Tc = 25°C

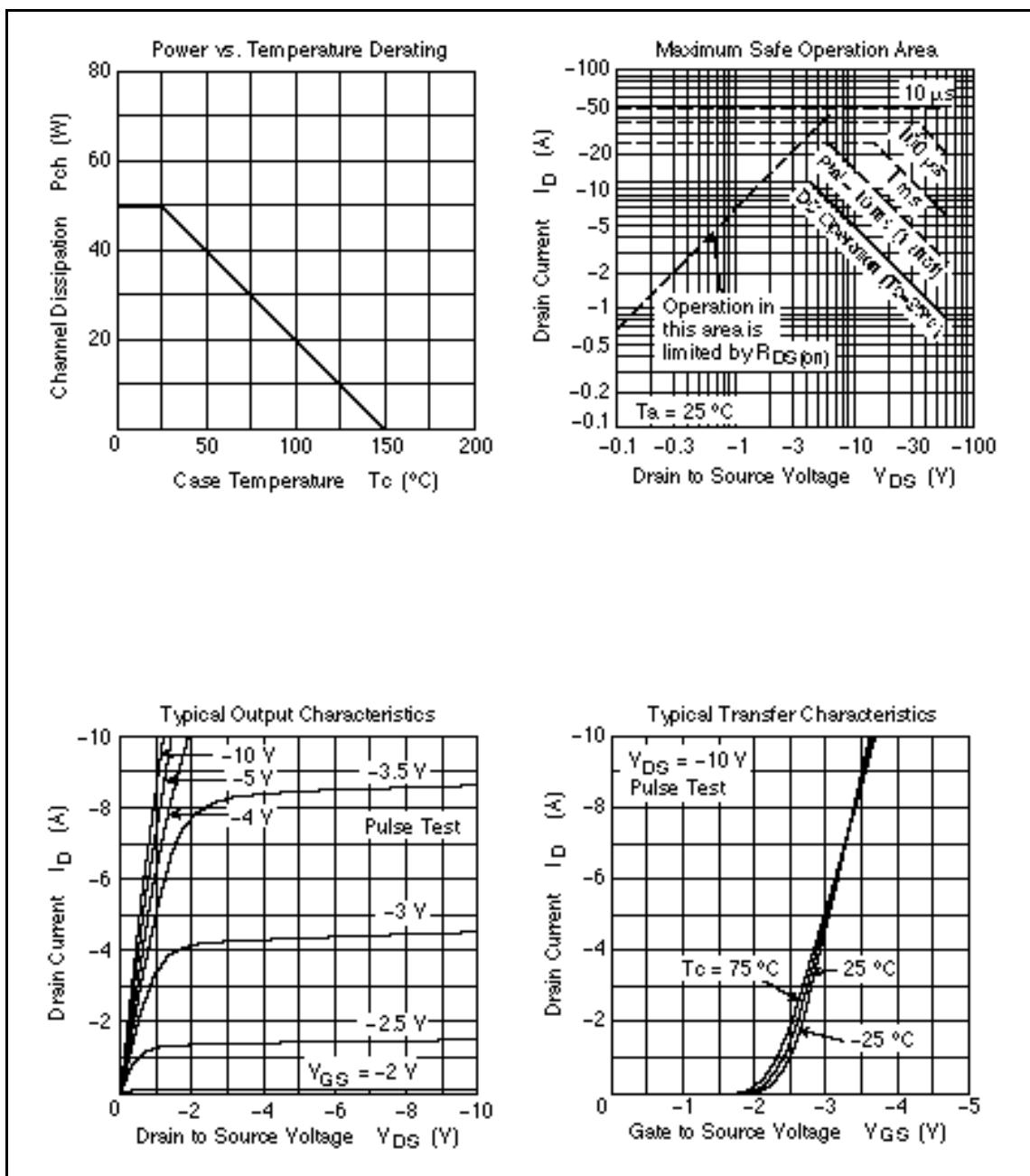
3. Value at Tch = 25°C, R_g 50

Electrical Characteristics (Ta = 25°C)

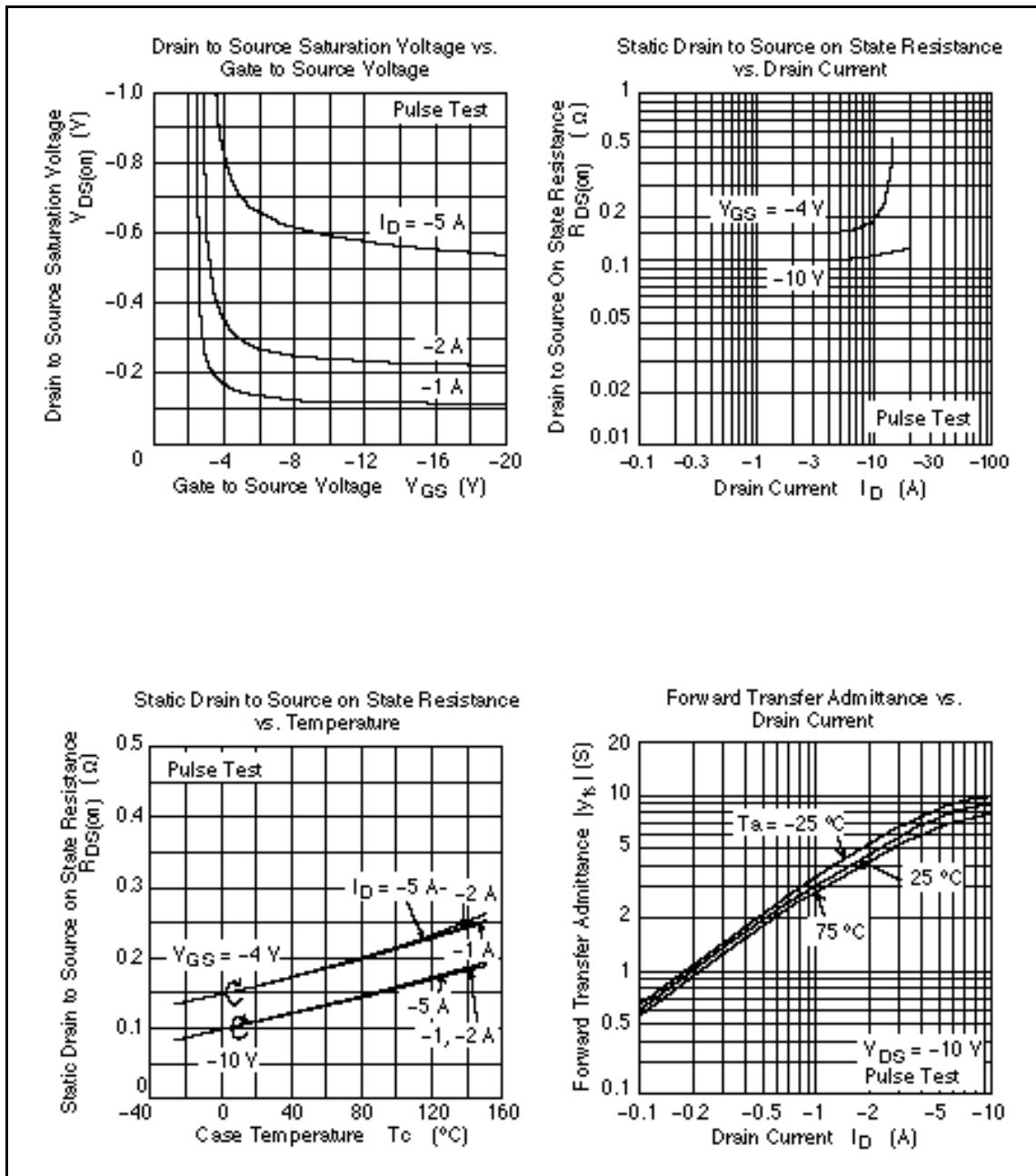
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	V _{(BR)DSS}	-60	—	—	V	I _D = -10mA, V _{GS} = 0
Gate to source breakdown voltage	V _{(BR)GSS}	±20	—	—	V	I _G = ±100μA, V _{DS} = 0
Zero gate voltage drain current	I _{DSS}	—	—	-10	μA	V _{DS} = -60 V, V _{GS} = 0
Gate to source leak current	I _{GSS}	—	—	±10	μA	V _{GS} = ±16V, V _{DS} = 0
Gate to source cutoff voltage	V _{GS(off)}	-1.0	—	-2.0	V	I _D = -1mA, V _{DS} = -10V
Static drain to source on state resistance	R _{DS(on)}	—	0.11	0.15		I _D = -6A, V _{GS} = -10V ^{Note4}
	R _{DS(on)}	—	0.16	0.23		I _D = -6A, V _{GS} = -4V ^{Note4}
Forward transfer admittance	y _{fs}	5	8	—	S	I _D = -6A, V _{DS} = -10V ^{Note4}
Input capacitance	C _{iss}	—	580	—	pF	V _{DS} = -10V
Output capacitance	C _{oss}	—	300	—	pF	V _{GS} = 0
Reverse transfer capacitance	C _{rss}	—	85	—	pF	f = 1MHz
Turn-on delay time	t _{d(on)}	—	10	—	ns	V _{GS} = -10V, I _D = -6A
Rise time	t _r	—	55	—	ns	R _L = 6
Turn-off delay time	t _{d(off)}	—	85	—	ns	
Fall time	t _f	—	60	—	ns	
Body-drain diode forward voltage	V _{DF}	—	-1.2	—	V	I _D = -12A, V _{GS} = 0
Body-drain diode reverse recovery time	t _{rr}	—	60	—	ns	I _F = -12A, V _{GS} = 0 diF/dt = 50A/μs

Note: 4. Pulse test

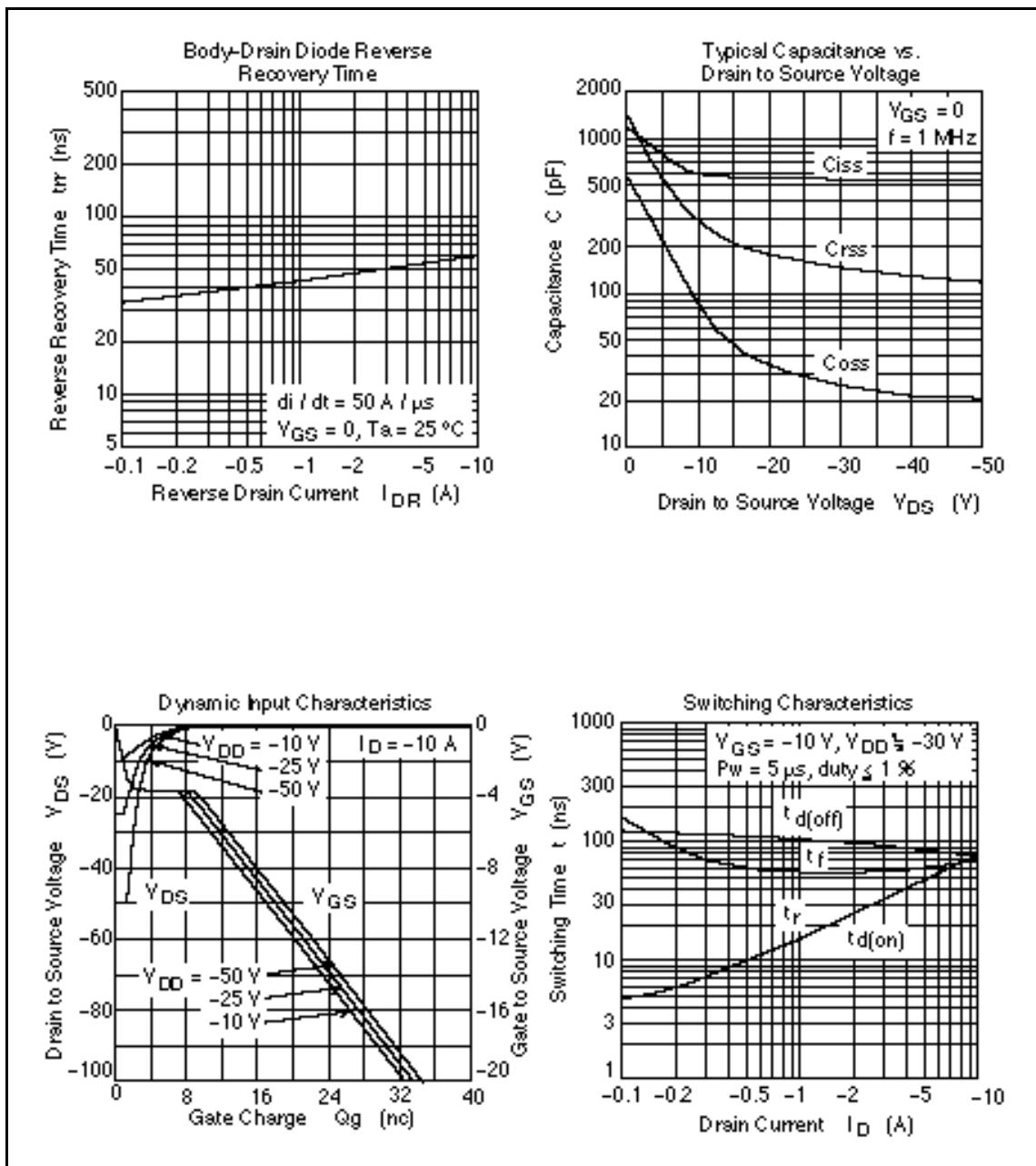
Main Characteristics



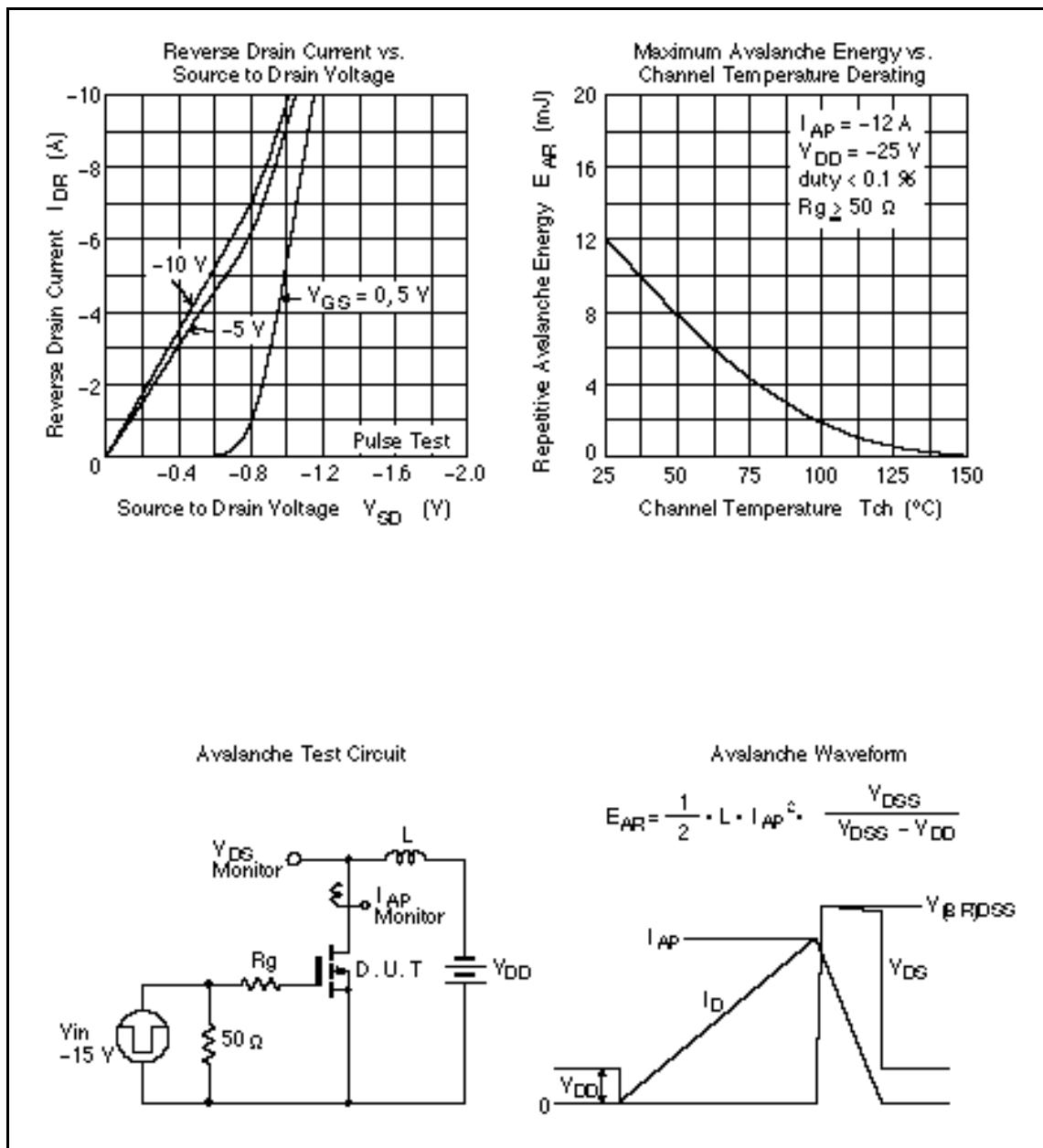
2SJ549(L),2SJ549(S)

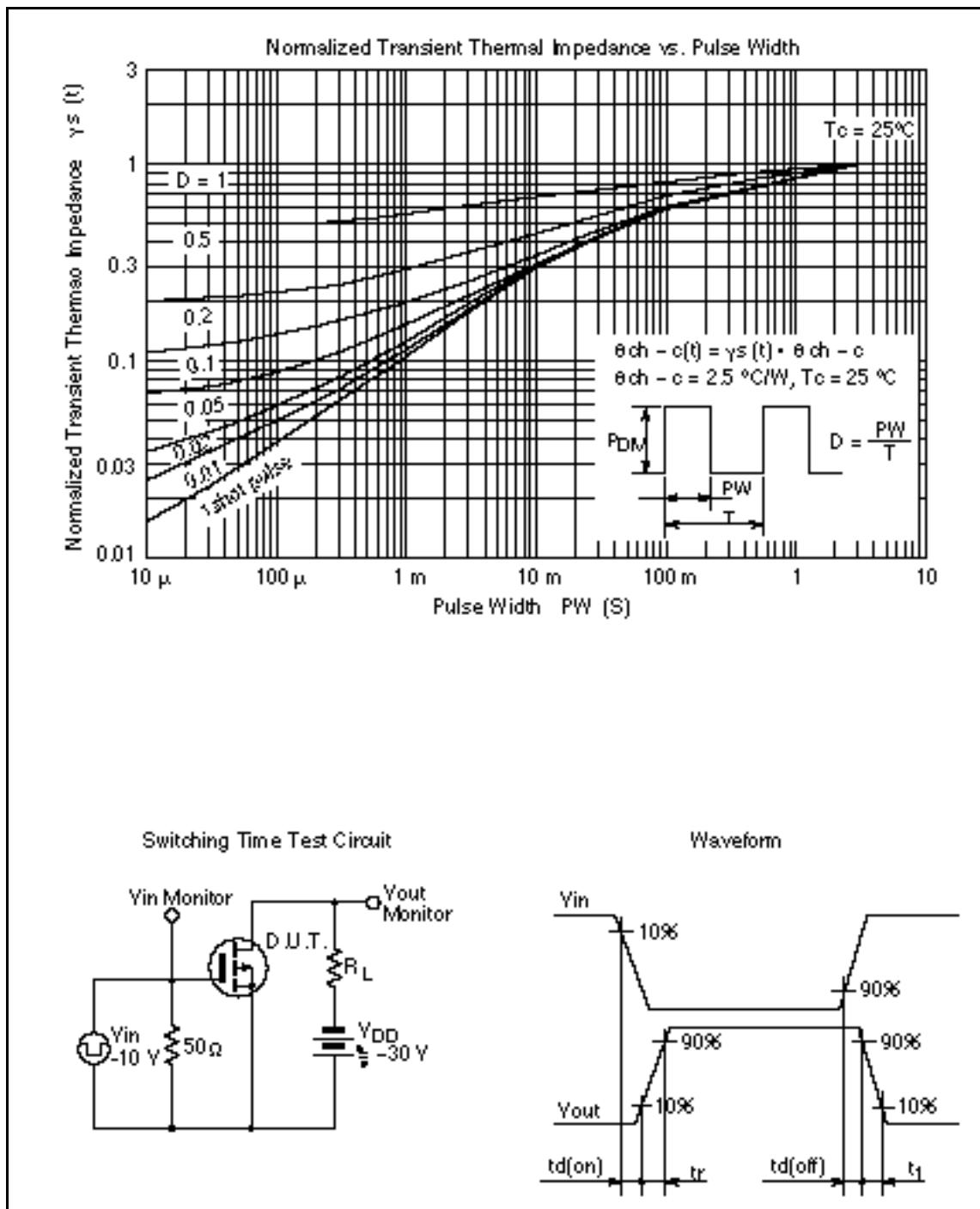


2SJ549(L),2SJ549(S)



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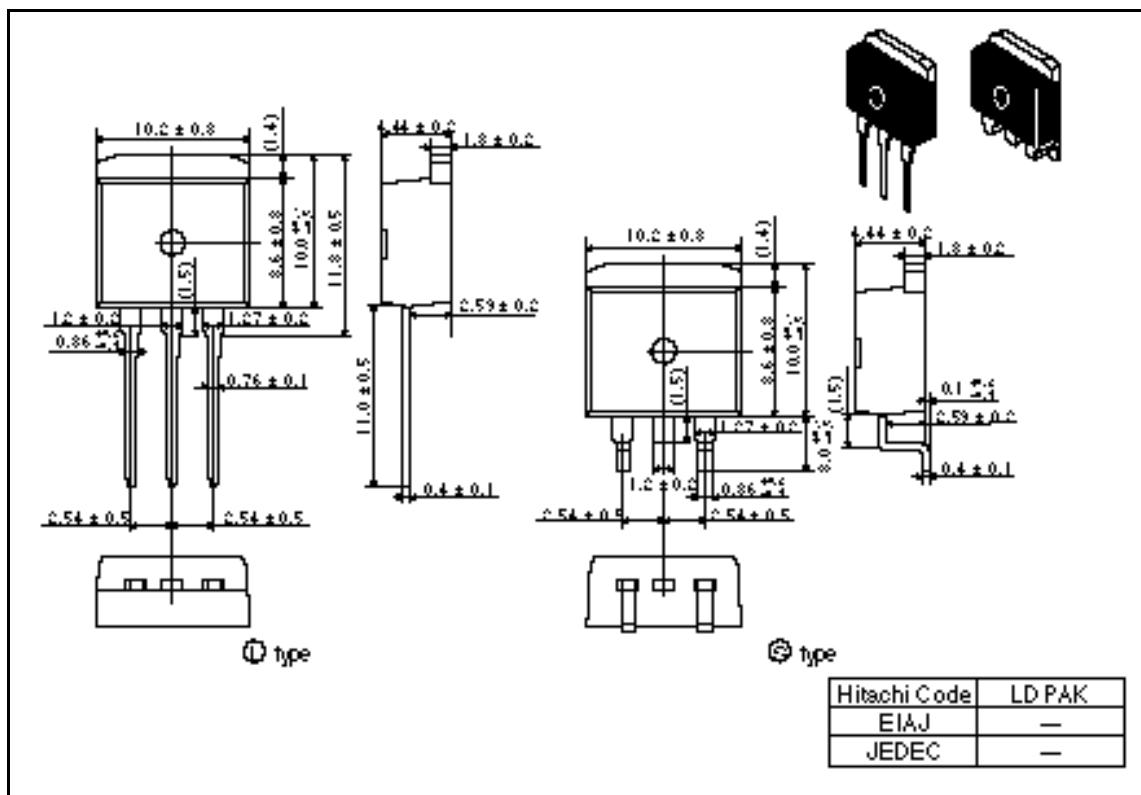




2SJ549(L),2SJ549(S)

Package Dimensions

Unit: mm



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